Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
09/911,873	IKEDA ET AL.
Examiner	Art Unit
Benny Q. Tieu	2614

SEARCHED			
Class	Subclass	Date	Examiner
455	92 414.1 414.3 432.3	4/15/2006	BQT

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SE/	ARCH NOTES SEARCH STRATEG	Y)
	DATE	EXMR
EAST	5/26/2005	BQT
EAST	4/15/2006	BQT
EAST	9/4/2006	BQT
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